Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/827,515	OHISHI ET AL.		
Examiner	Art Unit		
John J. Figueroa	1712		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	 				
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(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
WEST (searched key terms; see attached search summary)	7/6/2006	JJF
PALM (Inventor Name Search)	7/7/2006	JJF